

P-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}$ (Ω)	I _D (A) ^a	Q _g (Typ.)			
- 60	0.068 at V _{GS} = - 10 V	- 6.7	10.1 nC			
- 00	0.079 at V _{GS} = - 4.5 V	- 0.7				

FEATURES

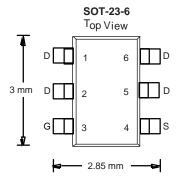
- DT-Trench Power MOSFET
- 100% R_g and UIS tested

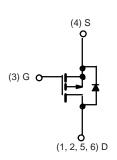
APPLICATIONS

- Load Switch
- DC/DC converter



RoHS COMPLANT





P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25 ^{\circ}C$, $P_{arameter}$		Symbol	Limit	Unit	
Drain-Source Voltage		V _{DS}	- 60		
Gate-Source Voltage		V _{GS}	± 20	V	
	T _C = 25 °C		- 6.7		
Continuous Drain Current (T _{.1} = 150 °C)	$T_C = 70 ^{\circ}C$	- I _D	- 5.1		
Continuous Diain Current (1 j = 130 G)	T _A = 25 °C	טי	- 4.1 ^{b, c}		
	T _A = 70 °C		- 3.3 ^{b, c}	Α	
Pulsed Drain Current		I _{DM}	- 26.8		
	T _C = 25 °C		- 6.7		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 1.67 ^{b, c}		
	T _C = 25 °C		6.5		
Max mum Power Dissipation	$T_C = 70 ^{\circ}C$	P _D	4.0	W	
Max mum Fower Dissipation	T _A = 25 °C	FD	2.0 ^{b, c}		
	T _A = 70 °C	1	1.3 ^{b, c}		
Operating Junction and Storage Temperatur	e Range	T_J,T_stg	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter	Sym bol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 5 s	R_{thJA}	35	60	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R_{thJF}	20	41	5/11	

Notes:

- a. Based on T_C = 25 °C
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 110 °C/W.

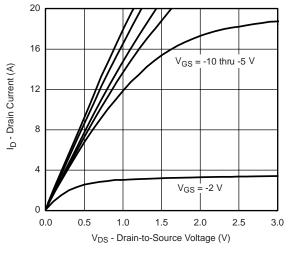


Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 60			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$ $I_D = -250 \mu A$			- 31		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = - 230 μΑ		4.5		mv/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Cata Valta na Duais Comunit	_	V _{DS} = - 48 V, V _{GS} = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 48 V, V _{GS} = 0 V, T _J = 55 °C			- 10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le$ - 10 V, V_{GS} = - 10 V	- 6.7			Α
	Б	$V_{GS} = -10 \text{ V}, I_D = -3.5 \text{ A}$		0.068 0.082		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 4.5 V, I _D = - 2.0 A		0.079	0.096	Ω
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 30 V, I _D = - 3.5 A		10	S	
Dynamic ^b					·	
Input Capacitance	C _{iss}			2200		
Output Capacitance	C _{oss}	$V_{DS} = -48 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		480		pF
Reverse Transfer Capacitance	C _{rss}			63		
Total Octo Ohama	Qg	V _{DS} = - 48 V, V _{GS} = - 10 V, I _D = - 3.5 A		20	35	20
Total Gate Charge				10	15	
Gate-Source Charge	Q _{gs}	V _{DS} = - 48 V, V _{GS} = - 4.5 V, I _D = - 2.0 A		3.5		nC
Gate-Drain Charge	Q_{gd}			3.8		
Gate Resistance	R _g	f = 1 MHz		9		Ω
Turn-On Delay Time	t _{d(on)}			40		
Rise Time	t _r	$V_{DD} = -15 \text{ V}, R_{L} = 4.6 \Omega$		28		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 3.3 A, V_{GEN} = - 2.0 V, R_g = 1 Ω		33		
Fall Time	t _f			16		
Turn-On Delay Time	t _{d(on)}			10		ns
Rise Time	t _r	V_{DD} = - 15 V, R_L = 4.6 Ω		8		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong -3.5 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		39		1
Fall Time	t _f			18		1
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 6.7	
Pulse Diode Forward Current ^a	I _{SM}				- 26.8	A
Body Diode Voltage	V _{SD}	I _S = - 3.5 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}			35		ns
Body Diode Reverse Recovery Charge	Q _{rr}			40		nC
Reverse Recovery Fall Time	t _a	$I_F = -3.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		24		ns
Reverse Recovery Rise Time	t _b			9	1	

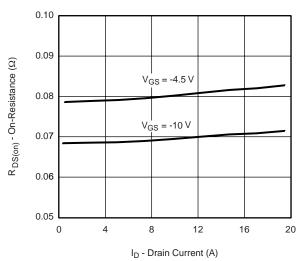
- a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

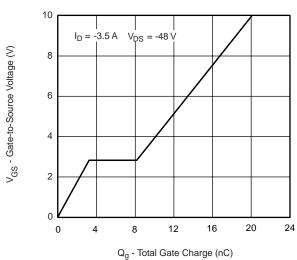




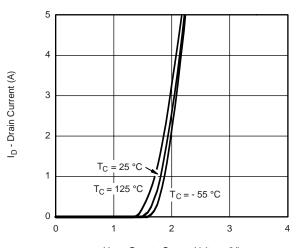
Output Characteristics



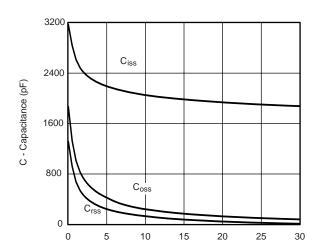
On-Resistance vs. Drain Current and Gate Voltage



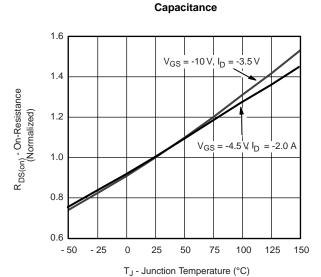
Gate Charge



V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**

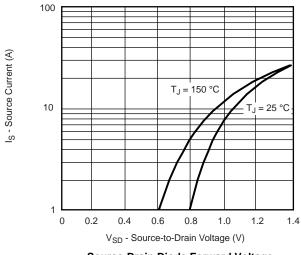


V_{DS} - Drain-to-Source Voltage (V)

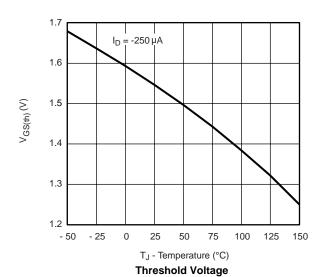


On-Resistance vs. Junction Temperature



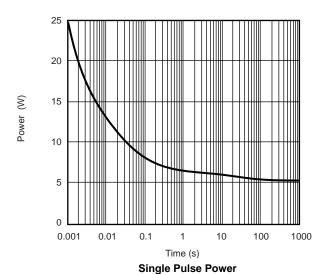


Source-Drain Diode Forward Voltage



0.25 $I_D = -3.5 A$ 0.20 $\mathsf{R}_{\mathsf{DS}(\mathsf{on})}$ - On-Resistance (Ω) 0.15 $T_J = 125$ °C 0.10 0.05 T_J = 25 °C 0.00 2 4 6 0 8 10

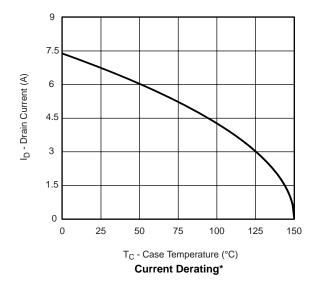
V_{GS} - Gate-to-Source Voltage (V) On-Resistance vs. Gate-to-Source Voltage

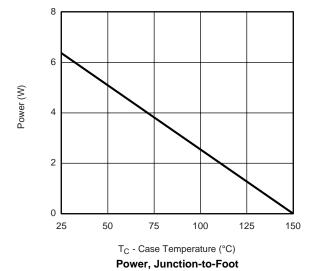


100 Limited by R_{DS(on)} 10 I_D - Drain Current (A) ш 100 ms 10 s 0.1 T_A = 25 °C Single Pulse DC Limited 0.01 0.1 100 V_{DS} - Drain-to-Source Voltage (V)

* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area



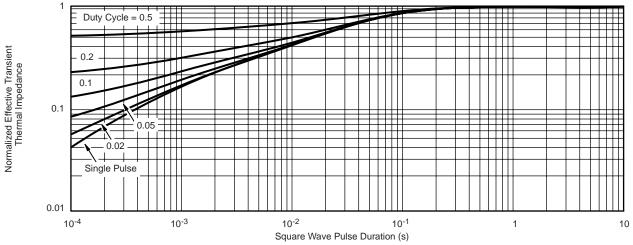


^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

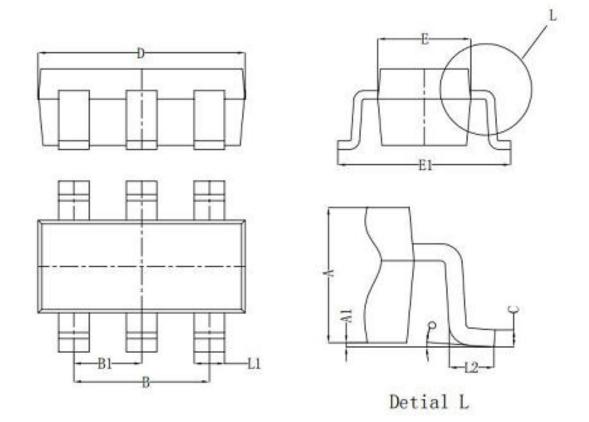


Normalized Thermal Transient Impedance, Junction-to-Foot



Din-Tek SEMICONDUCTOR

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COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	
А	0.95	1.10	1.35	
A1	0.00	0.05	0.12	
L1	0.25	0.40	0.55	
С	0.08	0.15	0.22	
D	2.77	2.92	3.12	
E	1.45	1.60	1.75	
E1	2.50	2.80	3.10	
В	1.75	1.90	2.10	
B1	0.95TYP			
L2	0.28	0.45	0.63	
0	0°	4°	8°	



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